## FEATURES

SNR = $\mathbf{5 4} \mathbf{~ d B}$ with 99 MHz analog input
500 MHz analog bandwidth
On-chip reference and track and hold
1.5 V p-p differential analog input range
5.0 V and 3.3 V supply operation
3.3 V CMOS/TTL outputs

Power: 2.1 W typical at 210 MSPS
Demultiplexed outputs each at 105 MSPS
Output data format option
Data sync input and data clock output provided
Interleaved or parallel data output option

## APPLICATIONS

## Communications and radars

Local multipoint distribution services (LMDS)
High-end imaging systems and projectors
Cable reverse paths
Point-to-point radio links

## GENERAL DESCRIPTION

The AD9410 is a 10 -bit monolithic sampling analog-to-digital converter (ADC) with an on-chip track-and-hold circuit and is optimized for high speed conversion and ease of use. The product operates at a 210 MSPS conversion rate, with outstanding dynamic performance over its full operating range.

The ADC requires a 5.0 V and 3.3 V power supply and up to a 210 MHz differential clock input for full performance operation. No external reference or driver components are required for many applications. The digital outputs are TTL-/CMOS-compatible and separate output power supply pins also support interfacing with 3.3 V logic.

The clock input is differential and TTL-/CMOS-compatible. The 10-bit digital outputs can be operated from $3.3 \mathrm{~V}(2.5 \mathrm{~V}$ to 3.6 V ) supplies. Two output buses support demultiplexed data up to 105 MSPS rates and binary or twos complement output coding format is available. A data sync function is provided for timing-dependent applications. An output clock simplifies interfacing to external logic. The output data bus timing is selectable for parallel or interleaved mode, allowing for flexibility in latching output data.

Rev. A
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Fabricated on an advanced BiCMOS process, the AD9410 is available in an 80 -lead thin quad flat package, exposed pad specified over the industrial temperature range $\left(-40^{\circ} \mathrm{C}\right.$ to $\left.+85^{\circ} \mathrm{C}\right)$.

## PRODUCT HIGHLIGHTS

1. High Resolution at High Speed-The architecture is specifically designed to support conversion up to 210 MSPS with outstanding dynamic performance.
2. Demultiplexed Output-Output data is decimated by two and provided on two data ports for ease of data transport.
3. Output Data Clock-The AD9410 provides an output data clock synchronous with the output data, simplifying the timing between data and other logic.
4. Data Synchronization-A DS input is provided to allow for synchronization of two or more AD9410s in a system, or to synchronize data to a specific output port in a single AD9410 system.

## AD9410

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## SPECIFICATIONS

## DC SPECIFICATIONS

$\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{D}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{CC}}=5.0 \mathrm{~V} ; 2.5 \mathrm{~V}$ external reference; $\mathrm{A}_{\mathrm{IN}}=-0.5 \mathrm{dBFS}$; clock input $=210 \mathrm{MSPS} ; \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$; unless otherwise noted.
Table 1.

| Parameter | Temp | Test Level | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| RESOLUTION |  |  |  | 10 |  | Bits |
| DC ACCURACY |  |  |  |  |  |  |
| No Missing Codes | Full | IV |  | Guaranteed |  |  |
| Differential Nonlinearity | $25^{\circ} \mathrm{C}$ | I | -1.0 | $\pm 0.5$ | +1.25 | LSB |
|  | Full | VI | -1.0 |  | +1.5 | LSB |
| Integral Nonlinearity | $25^{\circ} \mathrm{C}$ | 1 | -2.5 | $\pm 1.65$ | +2.5 | LSB |
|  | Full | VI | -3.0 |  | +3.0 | LSB |
| Gain Error | $25^{\circ} \mathrm{C}$ | I | -6.0 | 0 | +6.0 | \% FS |
| Gain Temperature Coefficient | Full | V |  | 130 |  | $\mathrm{ppm} /{ }^{\circ} \mathrm{C}$ |
| ANALOG INPUT |  |  |  |  |  |  |
| Input Voltage Range (With Respect to $\overline{A_{I N}}$ ) | Full | V |  | $\pm 768$ |  | $m V p-p$ |
| Common-Mode Voltage | Full | V |  | 3.0 |  | V |
| Input Offset Voltage | $25^{\circ} \mathrm{C}$ | I | -15 | +3 | +15 | mV |
|  | Full | VI | -20 |  | +20 | mV |
| Reference Voltage | Full | VI | 2.4 | 2.5 | 2.6 |  |
| Reference Temperature Coefficient | Full | V |  | 50 |  | ppm $/{ }^{\circ} \mathrm{C}$ |
| Input Resistance | Full | VI | 610 | 875 | 1250 | $\Omega$ |
| Input Capacitance | $25^{\circ} \mathrm{C}$ | V |  | 3 |  | pF |
| Analog Bandwidth, Full Power | $25^{\circ} \mathrm{C}$ | V |  | 500 |  | MHz |
| POWER SUPPLY |  |  |  |  |  |  |
| Power Dissipation AC ${ }^{1}$ | $25^{\circ} \mathrm{C}$ | V |  | 2.1 |  | W |
| Power Dissipation DC ${ }^{2}$ | Full | VI |  | 2.0 | 2.4 | W |
| $\mathrm{lvcc}^{2}$ | Full | VI |  | 128 | 145 | mA |
| $1 \mathrm{vo}{ }^{2}$ | Full | VI |  | 401 | 480 | mA |
| Power Supply Rejection Ratio, PSRR | $25^{\circ} \mathrm{C}$ | 1 | -7.5 | +0.5 | +7.5 | $\mathrm{mV} / \mathrm{V}$ |

[^0]
## AD9410

## SWITCHING SPECIFICATIONS

$\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{D}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{CC}}=5.0 \mathrm{~V} ; 2.5 \mathrm{~V}$ external reference; $\mathrm{A}_{\mathrm{IN}}=-0.5 \mathrm{dBFS}$; clock input $=210 \mathrm{MSPS} ; \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$; unless otherwise noted.
Table 2.

| Parameter | Temp | Test Level | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SWITCHING PERFORMANCE |  |  |  |  |  |  |
| Maximum Conversion Rate | Full | VI | 210 |  |  | MSPS |
| Minimum Conversion Rate | Full | IV |  |  | 100 | MSPS |
| Clock Pulse Width High, $\mathrm{t}_{\mathrm{H}}$ | $25^{\circ} \mathrm{C}$ | IV | 1.2 | 2.4 |  | ns |
| Clock Pulse Width Low, tel | $25^{\circ} \mathrm{C}$ | IV | 1.2 | 2.4 |  | ns |
| Aperture Delay, $\mathrm{t}_{\mathrm{A}}$ | $25^{\circ} \mathrm{C}$ | V |  | 1.0 |  | ns |
| Aperture Uncertainty (Jitter) | $25^{\circ} \mathrm{C}$ | V |  | 0.65 |  | ps rms |
| Output Valid Time, tv | Full | VI | 3.0 |  |  | ns |
| Output Propagation Delay, tPD | Full | VI |  |  | 7.4 | ns |
| Output Rise Time, $\mathrm{t}_{\mathrm{R}}$ | $25^{\circ} \mathrm{C}$ | V |  | 1.8 |  | ns |
| Output Fall Time, $\mathrm{t}_{\text {F }}$ | $25^{\circ} \mathrm{C}$ | V |  | 1.4 |  | ns |
| CLKOUT Propagation Delay, tcPD ${ }^{1}$ | Full | VI | 2.6 | 4.8 | 6.4 | ns |
| Data to DCO Skew, ( $\mathrm{tPD}^{\text {- }}$ (CPD $)$ | Full | IV | 0 | 1 | 2 | ns |
| DS Setup Time, tsos | Full | IV | 0.5 |  |  | ns |
| DS Hold Time, $\mathrm{t}_{\text {HDS }}$ | Full | IV | 0 |  |  | ns |
| Interleaved Mode (A, B Latency) | Full | VI |  | $A=6, B=6$ |  | Cycles |
| Parallel Mode (A, B Latency) | Full | VI |  | $A=7, B=6$ |  | Cycles |

${ }^{1} \mathrm{C}_{\text {LOAD }}=5 \mathrm{pF}$.

## DIGITAL SPECIFICATIONS

$\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{D}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{CC}}=5.0 \mathrm{~V} ; 2.5 \mathrm{~V}$ external reference; $\mathrm{A}_{\mathrm{IN}}=-0.5 \mathrm{dBFS}$; clock input $=210 \mathrm{MSPS} ; \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$; unless otherwise noted.
Table 3.

| Parameter | Temp | Test Level | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DIGITAL INPUTS |  |  |  |  |  |  |
| DFS, Input Logic 1 Voltage | Full | IV | 4 |  |  | V |
| DFS, Input Logic 0 Voltage | Full | IV |  |  | 1 | V |
| DFS, Input Logic 1 Current | Full | V |  | 50 |  | $\mu \mathrm{A}$ |
| DFS, Input Logic 0 Current | Full | V |  | 50 |  | $\mu \mathrm{A}$ |
| I/P Input Logic 1 Current ${ }^{1}$ | Full | V |  | 400 |  | $\mu \mathrm{A}$ |
| I/P Input Logic 0 Current ${ }^{1}$ | Full | V |  | 1 |  | $\mu \mathrm{A}$ |
| CLK+, CLK- Differential Input Voltage | Full | IV | 0.4 |  |  | V |
| CLK+, CLK - Differential Input Resistance | Full | V |  | 1.6 |  | k $\Omega$ |
| CLK+, CLK- Common-Mode Input Voltage ${ }^{2}$ | Full | V |  | 1.5 |  | V |
| DS, $\overline{\mathrm{DS}}$ Differential Input Voltage | Full | IV | 0.4 |  |  | V |
| DS, $\overline{\mathrm{DS}}$ Common-Mode Input Voltage | Full | V |  | 1.5 |  | V |
| Digital Input Pin Capacitance | $25^{\circ} \mathrm{C}$ | V |  | 3 |  | pF |
| DIGITAL OUTPUTS |  |  |  |  |  |  |
| Logic 1 Voltage ( $\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}$ ) | Full | VI | $V_{D D}-0.05$ |  |  | V |
| Logic 0 Voltage ( $\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}$ ) | Full | VI |  |  | 0.05 | V |
| Output Coding |  |  |  | Binary | r Twos Complement |  |

[^1]
## AC SPECIFICATIONS

$\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{D}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{CC}}=5.0 \mathrm{~V} ; 2.5 \mathrm{~V}$ external reference; $\mathrm{A}_{\mathrm{IN}}=-0.5 \mathrm{dBFS}$; clock input $=210 \mathrm{MSPS} ; \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$; unless otherwise noted.
Table 4.

| Parameter | Temp | Test Level | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DYNAMIC PERFORMANCE |  |  |  |  |  |  |
| Transient Response | $25^{\circ} \mathrm{C}$ | V |  | 2 |  | ns |
| Overvoltage Recovery Time | $25^{\circ} \mathrm{C}$ | V |  | 2 |  | ns |
| Signal-to-Noise Ratio, SNR (Without Harmonics) |  |  |  |  |  |  |
|  | $25^{\circ} \mathrm{C}$ | 1 | 52.5 | 55 |  | dB |
| $\mathrm{fin}^{\text {f }}=82 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | I | 52 | 54 |  | dB |
| $\mathrm{fiN}_{\text {I }}=160 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | V |  | 53 |  | dB |
| Signal-to-Noise Ratio, SINAD (With Harmonics) |  |  |  |  |  |  |
| $\mathrm{fiN}_{\mathrm{IN}}=10.3 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 1 | 51 | 54 |  | dB |
| $\mathrm{fin}_{\text {I }}=82 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | I | 50 | 53 |  | dB |
| $\mathrm{fiN}_{\text {I }}=160 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | V |  | 52 |  | dB |
| Effective Number of Bits, ENOB |  |  |  |  |  |  |
| $\mathrm{f}_{\mathrm{IN}}=10.3 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 1 | 8.3 | 8.8 |  | Bits |
| $\mathrm{fiN}_{\mathrm{I}}=82 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | I | 8.1 | 8.6 |  | Bits |
| $\mathrm{fiN}_{\mathrm{I}}=160 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | V |  | 8.4 |  | Bits |
| Second Harmonic Distortion |  |  |  |  |  |  |
| $\mathrm{fiN}_{\text {I }}=10.3 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 1 | -56 | -65 |  | dBc |
| $\mathrm{fiN}_{\text {I }}=82 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | I | -55 | -63 |  | dBc |
| $\mathrm{fiN}_{\text {I }}=160 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | V |  | -65 |  | dBc |
| Third Harmonic Distortion |  |  |  |  |  |  |
| $\mathrm{fiN}_{\text {I }}=10.3 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 1 | -58 | -69 |  | dBc |
| $\mathrm{fiN}_{\text {I }}=82 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | I | -57 | -67 |  | dBc |
| $\mathrm{fiN}^{\text {}}=160 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | V |  | -62 |  | dBc |
| Spurious-Free Dynamic Range, SFDR |  |  |  |  |  |  |
| $\mathrm{fiN}_{\text {I }}=10.3 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | 1 | 56 | 61 |  | dBc |
| $\mathrm{fiN}_{\mathrm{IN}}=82 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | I | 54 | 60 |  | dBC |
| $\mathrm{fin}^{\mathrm{I}}=160 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | V |  | 58 |  | dBc |
| Two-Tone Intermod Distortion, IMD ${ }^{1}$ $\mathrm{f}_{\mathrm{N} 1}=80.3 \mathrm{MHz}, \mathrm{f}_{\mathrm{iN} 2}=81.3 \mathrm{MHz}$ | $25^{\circ} \mathrm{C}$ | V |  | 58 |  | dBFS |

${ }^{1} \mathrm{IN} 1, \mathrm{IN} 2$ level $=-7 \mathrm{dBFS}$.

## AD9410



Figure 2. Timing Diagram

## ABSOLUTE MAXIMUM RATINGS

Table 5.

| Parameter | Rating |
| :--- | :--- |
| $\mathrm{V}_{\mathrm{D}}, \mathrm{V}_{\mathrm{CC}}, \mathrm{V}_{\mathrm{DD}}$ | 6 V |
| Analog Inputs | 0 V to $\mathrm{V}_{\mathrm{CC}}+0.5 \mathrm{~V}$ |
| Digital Inputs | 0 V to $\mathrm{V}_{\mathrm{DD}}+0.5 \mathrm{~V}$ |
| VREF | 0 V to $\mathrm{V}_{\mathrm{D}}+0.5 \mathrm{~V}$ |
| Digital Output Current | 20 mA |
| Operating Temperature Range | $-55^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |
| Storage Temperature Range | $-65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$ |
| Maximum Junction Temperature ${ }^{1}$ | $150^{\circ} \mathrm{C}$ |

[^2]Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## EXPLAINATION OF TEST LEVELS Test Level

I. $100 \%$ production tested.
II. $\quad 100 \%$ production tested at $25^{\circ} \mathrm{C}$ and sample tested at specified temperatures.
III. Sample tested only.
IV. Parameter is guaranteed by design and characterization testing.
V. Parameter is a typical value only.
VI. $\quad 100 \%$ production tested at $25^{\circ} \mathrm{C}$; guaranteed by design and characterization testing for industrial temperature range.

## ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

## AD9410

## PIN CONFIGURATION AND FUNCTION DESCRIPTIONS



Figure 3. Pin Configuration

Table 6. Pin Function Descriptions

| Pin No. | Mnemonic | Function |
| :---: | :---: | :---: |
| $\begin{aligned} & 1,2,8,9,12,13,16, \\ & 17,20,21,24,27,28, \\ & 29,30,71,72,73,74, \\ & 77,78 \end{aligned}$ | AGND | Analog Ground. |
| 3, 7, 14, 15 | Vcc | 5 V Supply. (Regulate to within $\pm 5 \%$.) |
| 4 | REFout | Internal Reference Output. |
| 5 | REFin | Internal Reference Input. |
| 6 | DNC | Do Not Connect. |
| 10 | $\mathrm{Aln}_{\text {In }}$ | Analog Input-True. |
| 11 | $\overline{A_{\text {IN }}}$ | Analog Input-Complement. |
| 18 | CLK+ | Clock Input-True. |
| 19 | CLK- | Clock Input-Complement. |
| 22 | DS | Data Sync (Input)-True. Tie low if not used. |
| 23 | $\overline{\mathrm{DS}}$ | Data Sync (Input)—Complement. Float and decouple with $0.1 \mu \mathrm{~F}$ capacitor if not used. |
| $\begin{aligned} & 25,26,31,32,69,70 \\ & 75,76 \end{aligned}$ | $V_{D}$ | 3.3 V Analog Supply. (Regulate to within $\pm 5 \%$.) |
| 33, 40, 49, 52, 59, 68 | DGND | Digital Ground. |
| 34, 41, 48, 53, 60, 67 | $V_{\text {DD }}$ | 3.3 V Digital Output Supply. (2.5 V to 3.6 V) |
| 35 to 39 | $\mathrm{D}_{80}$ to $\mathrm{D}_{84}$ | Digital Data Output for Channel B. ( $\mathrm{LSB}=\mathrm{D}_{80}$.) |
| 42 to 46 | $\mathrm{D}_{85}$ to $\mathrm{D}_{89}$ | Digital Data Output for Channel B. $\left(\mathrm{MSB}=\mathrm{D}_{\text {в9 }}.\right)$ |
| 47 | $\mathrm{OR}_{\text {B }}$ | Data Overrange for Channel B. |
| 50 | $\overline{\mathrm{DCO}}$ | Clock Output-Complement. |


| Pin No. | Mnemonic | Function |
| :---: | :---: | :---: |
| 51 | DCO | Clock Output-True. |
| 54 to 58 | $\mathrm{D}_{\mathrm{A} 0}$ to $\mathrm{D}_{\text {A } 4}$ | Digital Data Output for Channel A ( $\mathrm{LSB}=\mathrm{D}_{\mathrm{A})}$ ). |
| 61 to 65 | $\mathrm{D}_{\text {A } 5}$ to $\mathrm{D}_{\text {A }}$ | Digital Data Output for Channel A (MSB = $\mathrm{D}_{\text {A9 }}$ ). |
| 66 | ORA | Data Overrange for Channel A. |
| 79 | DFS | Data Format Select. High = twos complement, and low = binary. |
| 80 | I/P | Interleaved or Parallel Output Mode. Low = parallel mode, and high = interleaved mode. If tying high, use a current limiting series resistor ( $2.5 \mathrm{k} \Omega$ ) to the 5 V supply. |

## TERMINOLOGY

## Analog Bandwidth

The analog input frequency at which the spectral power of the fundamental frequency (as determined by the FFT analysis) is reduced by 3 dB .

## Aperture Delay

The delay between the $50 \%$ point of the rising edge of the clock command and the instant at which the analog input is sampled.

## Aperture Uncertainty (Jitter)

The sample-to-sample variation in aperture delay.
Differential Analog Input Resistance, Differential Analog Input Capacitance, and Differential Analog Input Impedance The real and complex impedances measured at each analog input port. The resistance is measured statically and the capacitance and differential input impedances are measured with a network analyzer.

## Differential Analog Input Voltage Range

The peak-to-peak differential voltage that must be applied to the converter to generate a full-scale response. Peak differential voltage is computed by observing the voltage on a single pin and subtracting the voltage from the other pin, which is $180^{\circ}$ out of phase. Peak-to-peak differential is computed by rotating the inputs phase $180^{\circ}$ and taking the peak measurement again. The difference is then computed between both peak measurements.

## Differential Nonlinearity

The deviation of any code width from an ideal 1 LSB step.

## Effective Number of Bits (ENOB)

ENOB is calculated from the measured SINAD based on the equation

$$
E N O B=
$$

$\underbrace{\text { SINAD }_{\text {MEASURED }}-1.76 d B+20 \log \left(\frac{\text { Full Scale Amplitude }}{\text { Input Amplitude }}\right)}$
6.02

## Clock Pulse Width/Duty Cycle

Pulse width high is the minimum amount of time that the clock pulse should be left in Logic 1 state to achieve rated performance; pulse width low is the minimum time the clock pulse should be left in low state. At a given clock rate, these specifications define an acceptable clock duty cycle.

## Full-Scale Input Power

Expressed in dBm. Computed using the equation

$$
P O W E R_{\text {FULLSCALE }}=10 \log \left[\frac{V_{\text {FULLSCALE }_{\text {rms }}}}{\frac{|Z|_{\text {INPUT }}}{0.001}}\right]
$$

## Harmonic Distortion, Second

The ratio of the rms signal amplitude to the rms value of the second harmonic component, reported in dBc .

## Harmonic Distortion, Third

The ratio of the rms signal amplitude to the rms value of the third harmonic component, reported in dBc .

## Integral Nonlinearity

The deviation of the transfer function from a reference line measured in fractions of 1 LSB using a best straight line determined by a least-square curve fit.

## Minimum Conversion Rate

The clock rate at which the SNR of the lowest analog signal frequency drops by no more than 3 dB below the guaranteed limit.

## Maximum Conversion Rate

The clock rate at which parametric testing is performed.

## Output Propagation Delay

The delay between a differential crossing of CLK+ and CLK- and the time when all output data bits are within valid logic levels.

## Out-of-Range Recovery Time

Out-of-range recovery time is the time it takes for the ADC to reacquire the analog input after a transient from $10 \%$ above positive full scale to $10 \%$ above negative full scale, or from $10 \%$ below negative full scale to $10 \%$ below positive full scale.
Noise (For Any Range Within the ADC)

$$
V_{\text {NOISE }}=\sqrt{|Z| \times 0.001 \times 10\left(\frac{F S_{d B m}-S I G N A L_{d B F S}}{10}\right)}
$$

where:
$Z$ is the input impedance.
$F S$ is the full scale of the device for the frequency in question.
SIGNAL is the signal level within the ADC reported in dB
below full scale. This value includes both thermal and quantization noise.

## Power Supply Rejection Ratio (PSRR)

The ratio of a change in input offset voltage to a change in power supply voltage.

## Signal-to-Noise-and-Distortion (SINAD)

The ratio of the rms signal amplitude (set 0.5 dB below full scale) to the rms value of the sum of all other spectral components, including harmonics, but excluding dc.

## Signal-to-Noise Ratio (Without Harmonics)

The ratio of the rms signal amplitude (set at 0.5 dB below full scale) to the rms value of the sum of all other spectral components, excluding the first five harmonics and dc.

## Spurious-Free Dynamic Range (SFDR)

The ratio of the rms signal amplitude to the rms value of the peak spurious spectral component. The peak spurious component may or may not be a harmonic. It may be reported in dBc (that is, degrades as signal level is lowered) or dBFS (always related back to converter full scale).

## Transient Response Time

Transient response time is defined as the time it takes for the ADC to reacquire the analog input after a transient from $10 \%$ above negative full scale to $10 \%$ below positive full scale.

## Two-Tone Intermodulation Distortion Rejection

The ratio of the rms value of either input tone to the rms value of the worst third-order intermodulation product; reported in dBc .

## Two-Tone SFDR

The ratio of the rms value of either input tone to the rms value of the peak spurious component. The peak spurious component may or may not be an IMD product. May be reported in dBc (that is, degrades as signal level is lowered) or in dBFS (always related back to converter full scale).

## Worst Other Spur

The ratio of the rms signal amplitude to the rms value of the worst spurious component (excluding the second and third harmonic) reported in dBc .

Table 7. Output Coding (VREF $=2.5 \mathrm{~V}$ )

| Step | $\mathbf{A}_{\text {IN }}-\overline{\mathbf{A I N}^{\prime}}$ | Digital Outputs Offset Binary | Digital Outputs Twos Complement | $\mathrm{OR}_{\mathrm{A}}, \mathrm{OR}_{\mathrm{B}}$ |
| :---: | :---: | :---: | :---: | :---: |
|  | >+0.768 | 1111111111 | 0111111111 | 1 |
| 1023 | +0.768 | 1111111111 | 0111111111 | 0 |
| - | . | - |  | . |
| - | . | - 1000000 | - | - |
| 513 | +0.0015 | 1000000001 | 0000000001 | 0 |
| 512 | 0.0 | 1000000000 | 0000000000 | 0 |
| 511 | -0.0015 | 0111111111 | 1111111111 | 0 |
| . | . | - |  | - |
| - | - | - |  | - |
| 0 | -0.768 | 0000000000 | 1000000000 | 0 |
|  | <-0.768 | 0000000000 | 1000000000 | 1 |

## AD9410

## EQUIVALENT CIRCUITS



Figure 4. Equivalent Analog Input Circuit


Figure 5. Equivalent Reference Input Circuit


Figure 7. Equivalent Digital Output Circuit


Figure 8. Equivalent Reference Output Circuit


Figure 9. Equivalent DFS Input Circuit


Figure 10. Equivalent DS Input Circuit


Figure 11. Equivalent I/P Input Circuit

## TYPICAL PERFORMANCE CHARACTERISTICS



Figure 12. Single Tone at $40 \mathrm{MHz} ; 210 \mathrm{MSPS}$


Figure 13. Single Tone at $100 \mathrm{MHz} ; 210$ MSPS


Figure 14. Single Tone at 160 MHz; 210 MSPS


Figure 15. SNR/SINAD vs. AIN; 210 MSPS


Figure 16. SNR/SINAD vs. Sample Rate; $A_{i N}=70 \mathrm{MHz}$


Figure 17. SNR/SINAD vs. Clock Positive Pulse Width $\left(f_{S}=210 \mathrm{MSPS}, A_{I N}=70 \mathrm{MHz}\right)$

## AD9410



Figure 18. Two Tone Test $A_{I N} 1=80.3 \mathrm{MHz}, A_{I N} 2=81.3 \mathrm{MHz}$


Figure 19. SNR/SINAD vs. Temperature, $210 \mathrm{MSPS}, A_{i n}=70 \mathrm{MHz}$


Figure 20. Second and Third Harmonics vs. Temperature; $A_{\text {IN }}=70 \mathrm{MHz}, 210 \mathrm{MSPS}$


Figure 21. VREFout vs. Analog 5 V Supply


Figure 22. Power Supply Currents vs. Sample Rate


Figure 23. VREFOUT Vs. I LOAD


Figure 24. VREFout vs. Temperature


Figure 25. $t_{P D}, t_{v}, t_{C P D} v s$. Temperature

## THEORY OF OPERATION

The AD9410 architecture is optimized for high speed and ease of use. The analog inputs drive an integrated high bandwidth track-and-hold circuit that samples the signal prior to quantization by the flash 10-bit core. For ease of use, the part includes an on-board reference and input logic that accepts TTL, CMOS, or PECL levels.

## USING THE AD9410

## Clock Input

Any high speed ADC is extremely sensitive to the quality of the sampling clock provided by the user. A track-and-hold circuit is essentially a mixer, and any noise, distortion, or timing jitter on the clock combines with the desired signal at the ADC output. For that reason, considerable care has been taken in the design of the clock input of the AD9410, and the user is advised to give commensurate thought to the clock source. To limit SNR degradation to less than 1 dB , a clock source with less than 1.25 ps rms jitter is required for sampling at Nyquist (for example, the Valpey Fisher VF561). Note that required jitter accuracy is a function of input frequency and amplitude. Refer to the Analog Devices, Inc. AN-501 application note, Aperture Uncertainty and ADC System Performance, for more information.
The clock input is fully TTL/CMOS compatible. The clock input can be driven differentially or with a single-ended signal. Best performance is obtained when driving the clock differentially. Both clock inputs are self-biased to $1 / 3 \times V_{C C}$ by a high impedance resistor divider (see the Equivalent Circuits section). Singleended clocking, which can be appropriate for lower frequency or nondemanding applications, is accomplished by driving the clock input directly and placing a $0.1 \mu \mathrm{~F}$ capacitor at CLOCK.


Figure 26. Driving Single-Ended Clock Input at TTL/CMOS Levels
An example where the clock is obtained from a PECL driver is shown in Figure 27. Note that the PECL driver is ac-coupled to the clock inputs to minimize input current loading. The AD9410 can be dc-coupled to PECL logic levels, resulting in the clock input currents increasing to approximately 8 mA typical, which is due to the difference in dc bias between the clock inputs and a PECL driver (see the Equivalent Circuits section).


Figure 27. Driving the Clock Inputs Differentially

## ANALOG INPUT

The analog input to the AD9410 is a differential buffer. For best dynamic performance, impedances at $\mathrm{A}_{\text {IN }}$ and $\overline{\mathrm{A}_{\text {IN }}}$ should match. The analog input has been optimized to provide superior wideband performance and requires that the analog inputs be driven differentially. SNR and SINAD performance degrades significantly if the analog input is driven with a singleended signal. A wideband transformer, such as Mini-Circuits ADT1-1WT, can be used to provide the differential analog inputs for applications that require a single-ended-todifferential conversion. Both analog inputs are self-biased by an on-chip resistor divider to nominal 3 V (see the Equivalent Circuits section).

Special care was taken in the design of the Analog Input section of the AD9410 to prevent damage and corruption of data when the input is overdriven. The nominal input range is 1.5 V diff $\mathrm{p}-\mathrm{p}$.
The nominal differential input range is $768 \mathrm{mV} \mathrm{p}-\mathrm{p} \times 2$.


Figure 28. Typical Analog Input Levels

## DIGITAL OUTPUTS

The digital outputs are TTL/CMOS compatible for lower power consumption. The outputs are biased from a separate supply $\left(\mathrm{V}_{\mathrm{DD}}\right)$, allowing easy interface to external logic. The outputs are CMOS devices that swing from ground to $V_{D D}$ (with no dc load). It is recommended to minimize the capacitive load the ADC drives by keeping the output traces short ( $<1$ inch, for a total $\mathrm{C}_{\text {LOAD }}<5 \mathrm{pF}$ ). It is also recommended to place low value $(20 \Omega)$ series damping resistors on the data lines to reduce switching transient effects on performance.

## CLOCK OUTPUTS (DCO, $\overline{\mathrm{DCO}})$

The input clock is divided by two and available off-chip at DCO and $\overline{\mathrm{DCO}}$. These clocks can facilitate latching off-chip, providing a low skew clocking solution (see Figure 2). These clocks can also be used in multiple AD9410 systems to synchronize the ADCs. Depending on application, DCO or $\overline{\mathrm{DCO}}$ can be buffered and used to drive the DS inputs on a second AD9410, ensuring synchronization. The on-chip clock buffers should not drive more than 5 pF to 7 pF of capacitance to limit switching transient effects on performance.

## VOLTAGE REFERENCE

A stable and accurate 2.5 V voltage reference is built into the AD9410 (VREFout). The input range can be adjusted by varying the reference voltage. No appreciable degradation in performance occurs when the reference is adjusted $\pm 5 \%$. The full-scale range of the ADC tracks reference voltage changes linearly within the $\pm 5 \%$ tolerance.

## TIMING

The AD9410 provides latched data outputs, with six pipeline delays in interleaved mode (see Figure 2). In parallel mode, the Port A has one additional cycle of latency added on-chip to line up transitions at the data ports, resulting in a latency of seven cycles for the Port A. The length of the output data lines and loads placed on them should be minimized to reduce transients within the AD9410; these transients can detract from the dynamic performance of the converter.
The minimum guaranteed conversion rate of the AD9410 is 100 MSPS. At internal clock rates below 100 MSPS, dynamic performance may degrade. Note that lower effective sampling rates can be obtained simply by sampling just one output portdecimating the output by two. Lower sampling frequencies can also be accommodated by restricting the duty cycle of the clock such that the clock high pulse width is a maximum of 5 ns .

## DATA SYNC (DS)

The data sync input, DS, can be used in applications requiring that a given sample appear at a specific output Port A or Port B. When DS is held high, the ADC data outputs and clock do not switch and are held static. Synchronization is accomplished by the assertion (falling edge) of DS, within the timing constraints $\mathrm{t}_{\text {SDS }}$ and $\mathrm{t}_{\text {HDS }}$ relative to an clock rising edge. (On initial synchronization, $\mathrm{t}_{\mathrm{HDS}}$ is not relevant.) If DS falls within the required setup time ( $\mathrm{t}_{\text {sDs }}$ ) before a given clock rising edge N , the analog value at that point is digitized and available at Port B six cycles later (interleaved mode). The next sample, $\mathrm{N}+1$, is sampled by the next rising clock edge and available at Port A six cycles after that clock edge (interleaved mode). In dual parallel mode, Port A has a seven cycle latency, and Port B has a six cycle latency, but data is available at the same time.

## AD9410



## OUTLINE DIMENSIONS



ORDERING GUIDE

| Model | Temperature Range | Package Description | Option |
| :--- | :--- | :--- | :--- |
| AD9410BSVZ ${ }^{1}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $80-$ Lead Thin Quad Flat Package, Exposed Pad [TQFP_EP] | SV-80-4 |

[^3]
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## NOTES


[^0]:    ${ }^{1}$ Clock input $=210 \mathrm{MSPS}, \mathrm{A}_{\mathrm{IN}}=-0.5 \mathrm{dBFS}, 10 \mathrm{MHz}$ sine wave, $\mathrm{I}_{\mathrm{IVD}}=31 \mathrm{~mA}$ typical at $\mathrm{C}_{\text {LOAD }}=5 \mathrm{pF}$.
    ${ }^{2}$ Clock input $=210$ MSPS, $A_{i N}=d c$, outputs not switching.

[^1]:    ${ }^{1} \mathrm{I} / \mathrm{P}$ pin Logic $1=5 \mathrm{~V}$, Logic $0=$ GND. It is recommended to use a series $2.5 \mathrm{k} \Omega( \pm 10 \%)$ resistor to $\mathrm{V}_{\mathrm{DD}}$ when setting to Logic 1 to limit input current.
    ${ }^{2}$ See Clock Input section.

[^2]:    ${ }^{1}$ Adequate dissipation of power from the AD9410 relies on all power and ground pins of the device being soldered directly to a copper plane on a PCB. In addition, the thermally enhanced package of the AD9410BSVZ has an exposed paddle on the bottom that must be soldered to a large copper plane, which, for convenience, can be the ground plane. Sockets for package style of the AD9410 device are not recommended.

[^3]:    ${ }^{1} \mathrm{Z}=$ RoHS Compliant Part.

